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Author Correction: Observation of high nonlinearity in Bi doped $\text{Bi}_x\text{In}_{35-x}\text{Se}_{65}$ thin films with annealing

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The Acknowledgments section in the original version of this Article was incomplete.

“The author Dr. Naik would like to thank the Department of Physics, Indian Institute of Science (IISc.) for Optical, Raman, and FESEM measurements.”

now reads:

“The author Dr. Naik would like to thank the Department of Physics, Indian Institute of Science (IISc.) for Optical, Raman, and FESEM measurements. The usage of MNCF and NNCF facilities supported by Meity, DST and MOE are acknowledged.”

The original Article has been corrected.



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